



PATENT
Atty. Dkt. AMAT/3083.P1/FET/FET/DV

GP 2877

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:
Hunter

Serial No.: 09/680,226

Confirmation No.: 1604

Filed: October 6, 2000

For: Method and Apparatus for
Enhanced Embedded
Substrate Inspection
Through Process Data
Collection and Substrate
Imaging Techniques

Group Art Unit: 2877

Examiner: Unknown

#14/Suppl
3/8/03

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Commissioner for Patents
Washington, D.C. 20231

CERTIFICATE OF MAILING 37 CFR 1.8	
I hereby certify that this correspondence is being deposited on February 17, 2003 with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, Washington, D.C. 20231.	
February 17 2003 Date	 Signature

Dear Sir:

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

The Applicants, and the Attorney who signs below on the basis of the information supplied by the inventor and the information in his file, submit herewith patents, publications, or other information of which they are aware, which may be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR § 1.56.

While the information submitted in this Supplemental Information Disclosure Statement may be material pursuant to 37 CFR § 1.56, it is not intended to constitute an admission that any patent, publication, or other information referred to therein is prior art for this invention unless specifically designated as such.

In accordance with 37 CFR § 1.97, this Supplemental Information Disclosure Statement is not to be construed as a representation that a search has been made or that no other possibly material information as defined under 37 CFR § 1.56(a) exists.

02/27/2003 SZENDIE1 00000045 200782 09680226
01-FC:1806 180.00 CH

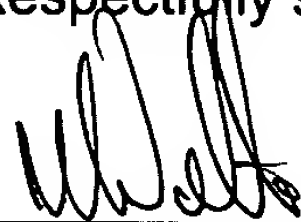
Adjustment date: 03/03/2003 SZENDIE1
02/27/2003 SZENDIE1 00000045 200782 09680226
01-FC:1806 -180.00 CR

The patents and/or publications submitted herewith are set forth on the attached Form PTO-1449.

Applicants certify that all references submitted with this disclosure were first cited in a communication from a foreign patent office dated January 10, 2003, which communication is enclosed, not more than three months prior to the filing of this Supplemental Information Disclosure Statement.

If the sum of \$180.00 is due under 37 CFR § 1.17(p) pursuant to § 1.97, the Commissioner is hereby authorized to charge this fee, and any other fee necessary to make this submission timely, to the Deposit Account No. 20-0782/APPM/3083.P1/BTP.

Respectfully submitted,



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U.S. Department of Commerce, Patent and Trademark Office (PTO Form 1449 modified)		Docket No. AMAT/3083.P1/FET/ FET/DV	Serial No. 09/680,226
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Applicant Hunter	Confirmation No.: 1604
(Use several sheets if necessary)		Filing Date October 6, 2000	Group 2877
	Examiner Unknown		

U.S. Patent Documents

*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
	A1	6,012,966	01/11/00	Ban, et al.	451	8	05/05/97
	A2						
	A3						
	A4						
	A5						
	A6						
	A7						
	A8						
	A9						
	A10						
	A11						
	A12						
	A13						

F reign Patent Documents

*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							YES	NO
	B1						<input type="checkbox"/>	<input type="checkbox"/>
	B2						<input type="checkbox"/>	<input type="checkbox"/>
	B3						<input type="checkbox"/>	<input type="checkbox"/>

OTHER ART

*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
	C1	Written Opinion (Form PCT/IPEA/408), dated January 10, 2003 for PCT/US01/42470
	C2	
	C3	

Examiner	Date Considered
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.	